

RoHS Compliant Product
A suffix of "-C" specifies halogen & lead-free

DESCRIPTION

The SSM5951 is the highest performance trench P-ch MOSFETs with extreme high cell density, which provide excellent $R_{DS(ON)}$ and gate charge for most of the synchronous buck converter applications.

The SSM5951 meet the RoHS and Green Product requirement with full function reliability approved.

FEATURES

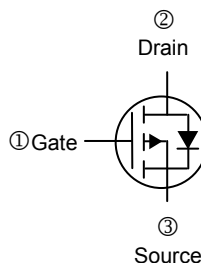
- Advanced High Cell Density Trench Technology
- Super Low Gate Charge
- Green Device Available

MARKING

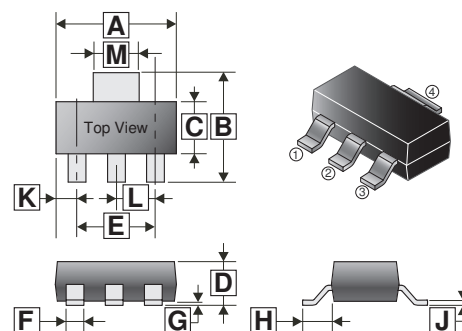


PACKAGE INFORMATION

| Package | MPQ | Leader Size |
|---------|------|-------------|
| SOT-223 | 2.5K | 13 inch |



SOT-223



| REF. | Millimeter | | REF. | Millimeter | |
|------|------------|------|------|------------|------|
| | Min. | Max. | | Min. | Max. |
| A | 5.90 | 6.70 | G | - | 0.18 |
| B | 6.70 | 7.30 | H | 2.00 REF. | |
| C | 3.30 | 3.80 | J | 0.20 | 0.40 |
| D | 1.40 | 1.90 | K | 1.10 REF. | |
| E | 4.45 | 4.75 | L | 2.30 REF. | |
| F | 0.60 | 0.85 | M | 2.80 | 3.20 |

ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ\text{C}$ unless otherwise specified)

| Parameter | Symbol | Rating | Unit | |
|--|-----------------|------------------------|-----------------------------|---|
| Drain-Source Voltage | V_{DS} | -30 | V | |
| Gate-Source Voltage | V_{GS} | ± 12 | V | |
| Continuous Drain Current @ $V_{GS}=10\text{V}$ ¹ | I_D | $T_A=25^\circ\text{C}$ | -2.6 | A |
| | | $T_A=70^\circ\text{C}$ | -2.1 | A |
| Pulsed Drain Current ³ | I_{DM} | -10.4 | A | |
| Total Power Dissipation | P_D | 1.5 | W | |
| Operating Junction and Storage Temperature Range | T_J, T_{STG} | -55~150 | $^\circ\text{C}$ | |
| Thermal Resistance Rating | | | | |
| Maximum Thermal Resistance from Junction to Ambient ¹ | $R_{\theta JA}$ | 85 | $^\circ\text{C} / \text{W}$ | |
| Maximum Thermal Resistance from Junction to Ambient ² | | 125 | | |
| Maximum Thermal Resistance from Junction to Case ¹ | $R_{\theta JC}$ | 60 | | |

ELECTRICAL CHARACTERISTICS ($T_J=25^\circ\text{C}$ unless otherwise specified)

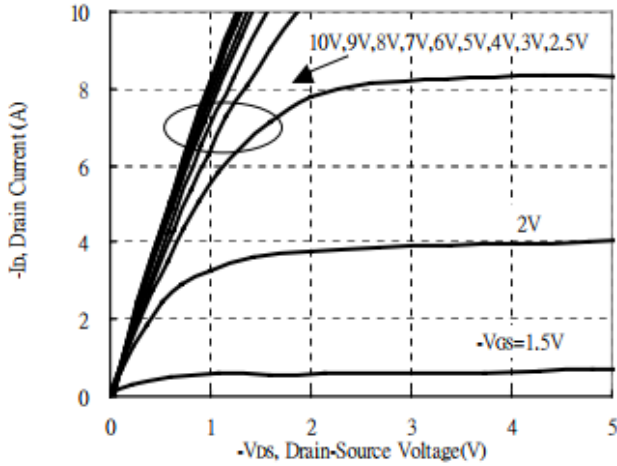
| Parameter | Symbol | Min. | Typ. | Max. | Unit | Test Condition |
|--|-----------------------|-------|------|-----------|------------|---|
| Drain-Source Breakdown Voltage | BV_{DSS} | -30 | - | - | V | $V_{GS}=0, I_D=-250\mu\text{A}$ |
| Gate Threshold Voltage | $V_{GS(th)}$ | -0.5 | - | -1.2 | V | $V_{DS}=V_{GS}, I_D=-250\mu\text{A}$ |
| Gate-Source Leakage Current | I_{GSS} | - | - | ± 100 | nA | $V_{GS}=\pm 12\text{V}$ |
| Drain-Source Leakage Current | I_{DSS} | - | - | -1 | uA | $V_{DS}=-30\text{V}, V_{GS}=0, T_J=25^\circ\text{C}$ |
| | | - | - | -5 | | $V_{DS}=-30\text{V}, V_{GS}=0, T_J=55^\circ\text{C}$ |
| Static Drain-Source On-Resistance ⁴ | $R_{DS(ON)}$ | - | - | 150 | m Ω | $V_{GS}=-10\text{V}, I_D=-2.6\text{A}$ |
| | | - | - | 166 | | $V_{GS}=-4.5\text{V}, I_D=-2\text{A}$ |
| | | - | - | 220 | | $V_{GS}=-2.5\text{V}, I_D=-1\text{A}$ |
| Total Gate Charge | $V_{GS}=-10\text{V}$ | Q_g | - | 11.6 | nC | $I_D=-1.4\text{A}$ $V_{DS}=-15\text{V}$ $V_{GS}=-10\text{V}$ |
| Total Gate Charge | $V_{GS}=-4.5\text{V}$ | Q_g | - | 5.6 | | |
| Gate-Source Charge | Q_{gs} | - | 1 | - | | |
| Gate-Drain Charge | Q_{gd} | - | 1.4 | - | | |
| Turn-On Delay Time | $T_{d(on)}$ | - | 4.4 | - | nS | $V_{DS}=-15\text{V}$ $I_D=-1.4\text{A}$ $V_{GS}=-10\text{V}$ $R_G=3\Omega$ |
| Rise Time | T_r | - | 17 | - | | |
| Turn-Off Delay Time | $T_{d(off)}$ | - | 34.6 | - | | |
| Fall Time | T_f | - | 4.6 | - | | |
| Input Capacitance | C_{iss} | - | 480 | - | pF | $V_{GS}=0$ $V_{DS}=-15\text{V}$ $f=1\text{MHz}$ |
| Output Capacitance | C_{oss} | - | 63 | - | | |
| Reverse Transfer Capacitance | C_{rss} | - | 33 | - | | |
| Source-Drain Diode | | | | | | |
| Forward On Voltage ⁴ | V_{SD} | - | - | -1 | V | $I_S=-1\text{A}, V_{GS}=0\text{V}$ |
| Continuous Source Current ¹ | I_S | - | - | -2.6 | A | |
| Pulsed Source Current ³ | I_{SM} | - | - | -10.4 | | |
| Reverse Recovery Time | t_{rr} | - | 7 | - | nS | $I_F=-1\text{A}, di/dt=100\text{A}/\mu\text{s},$ $T_J=25^\circ\text{C}$ |
| Reverse Recovery Charge | Q_{rr} | - | 2.9 | - | nC | |

Notes:

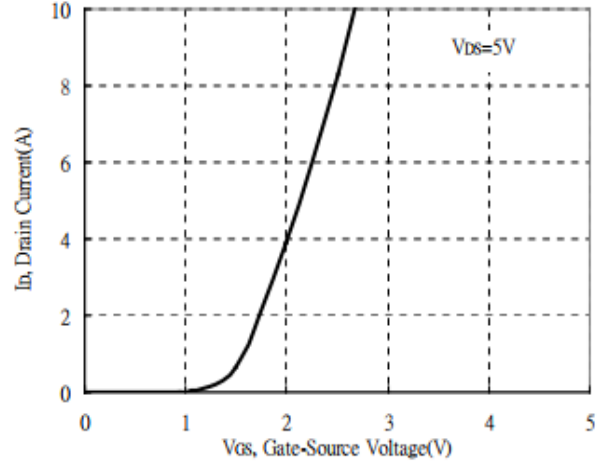
- Surface mounted on a 1 inch² FR4 board with 20Z copper
- When mounted on Min. copper pad.
- Pulse width limited by maximum junction temperature., $P_w \leq 300\mu\text{s}$, Duty cycle $\leq 1\%$
- The data tested by pulsed, pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$

TYPICAL CHARACTERISTIC CURVES

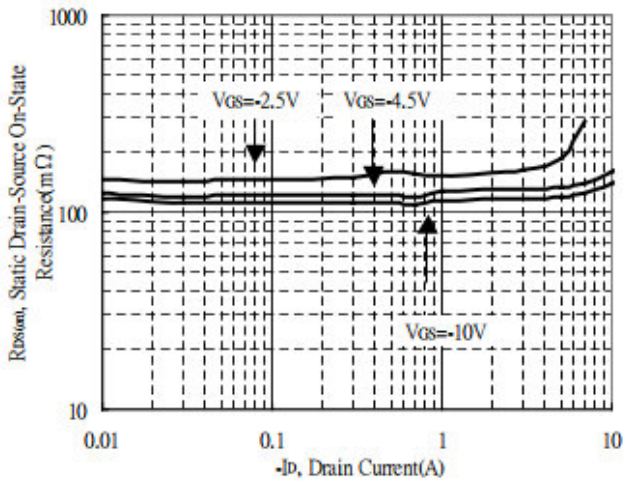
Typical Output Characteristics



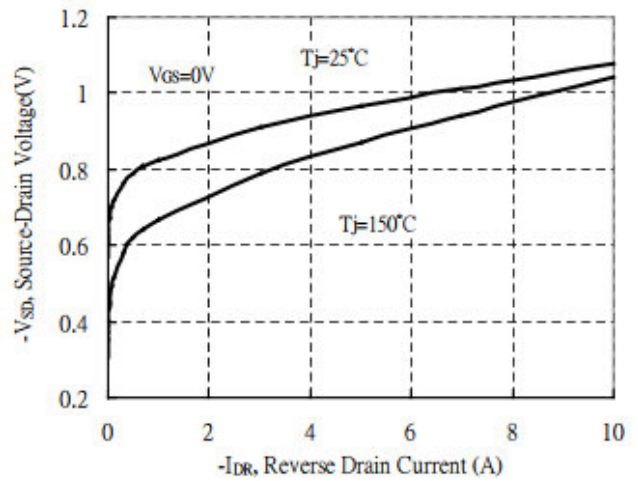
Typical Transfer Characteristics



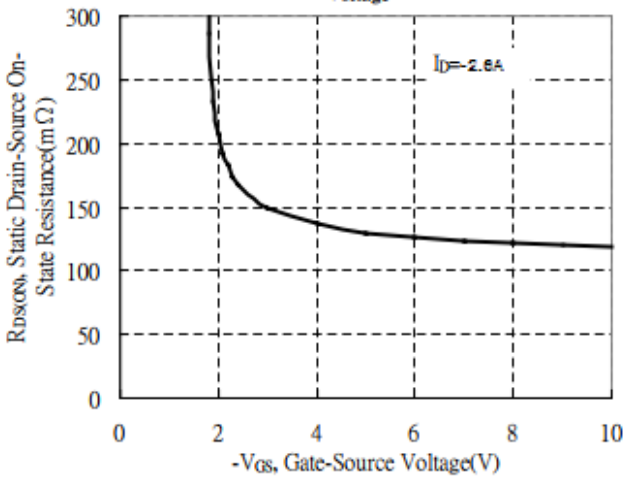
Static Drain-Source On-State resistance vs Drain Current



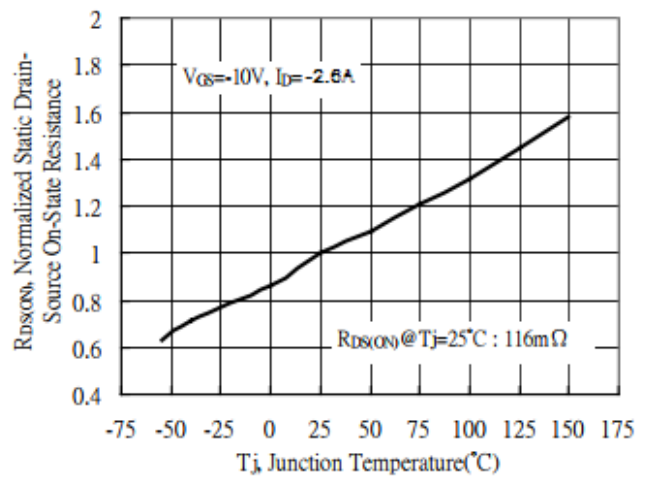
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

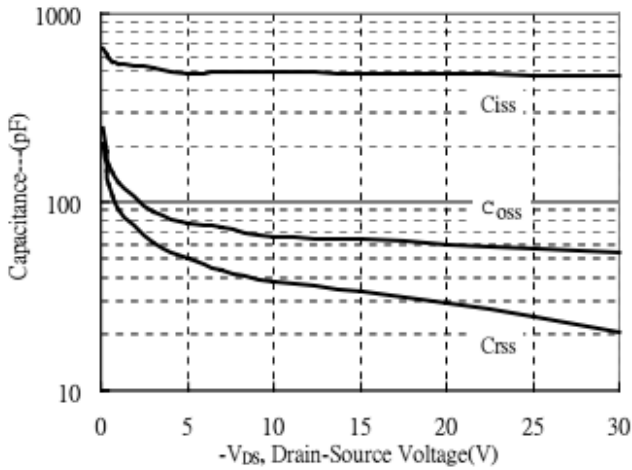


Drain-Source On-State Resistance vs Junction Temperature

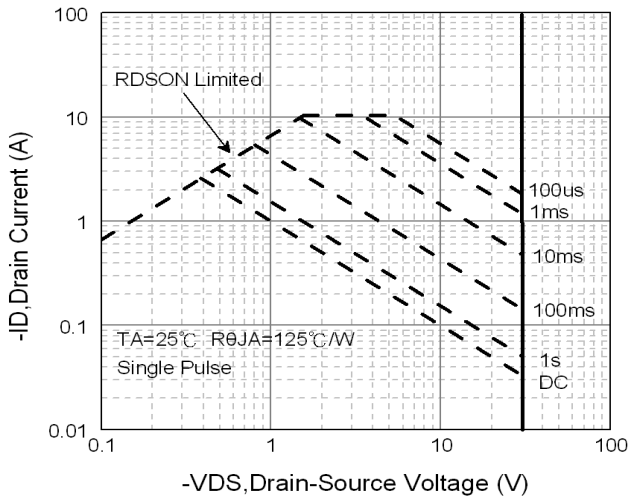
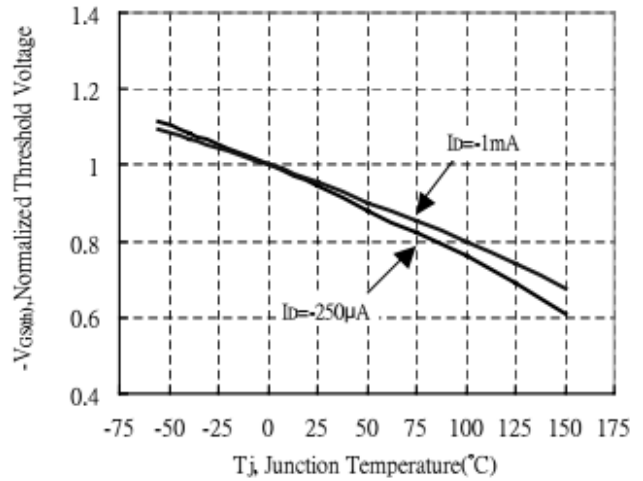


TYPICAL CHARACTERISTIC CURVES

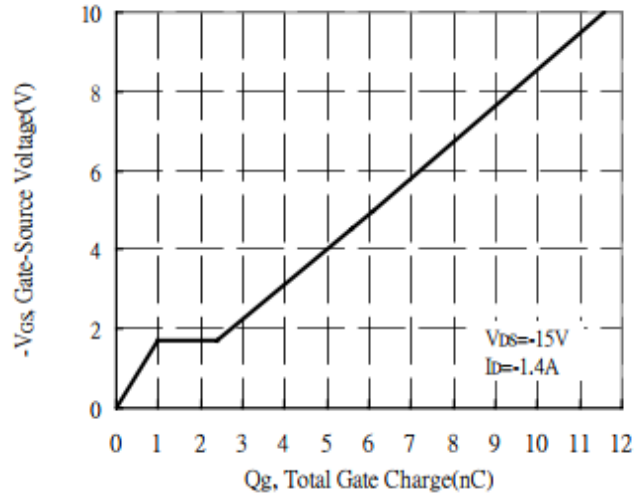
Capacitance vs Drain-to-Source Voltage



Threshold Voltage vs Junction Temperature



Gate Charge Characteristics



Transient Thermal Response Curves

